

QUADRUPLE BILATERAL SWITCH

DESCRIPTION

The M4016BP is a semiconductor integrated circuit consisting of four independent bilateral analog switches.

FEATURES

- Typical ON resistance of 250Ω (at $V_{DD} = 15V$)
- High off-state resistance $10^9\Omega$ or greater (typical)
- Small variations in ON resistance between switches in the same package:
10Ω (typical, at $V_{DD} = 15V$)
- Wide operating voltage range: $V_{DD} = 3 \sim 18V$
- Wide operating temperature range:
 $T_a = -40 \sim +85^\circ C$

APPLICATIONS

General purpose, for use in industrial and consumer digital equipment.

FUNCTIONAL DESCRIPTION

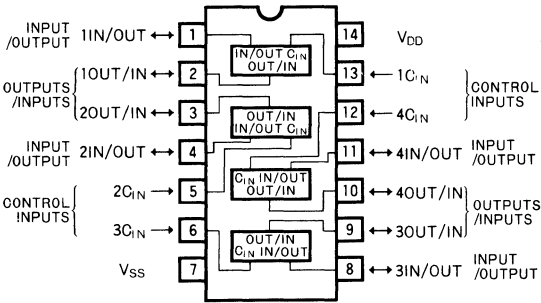
The control input (C_{IN}) can be used to change the input-to-output impedance (IN/OUT – OUT/IN) of the switches.

When (C_{IN}) is made high, the input-to-output switch impedance is low and when set to low, this impedance is high.

FUNCTION TABLE

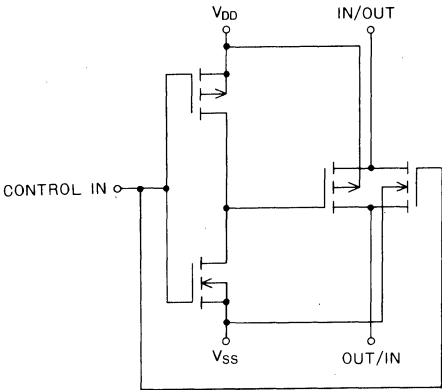
Input	INPUT/OUTPUT and OUTPUT/INPUT resistance ($V_{DD} = 10V, 15V$)
C_{IN}	
H	$2 \sim 20 \times 10^2 \Omega$
L	$> 10^9 \Omega$ typical

PIN CONFIGURATION (TOP VIEW)

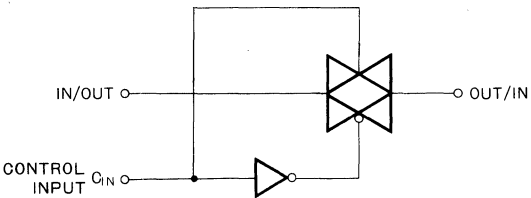


Outline 14P4

CIRCUIT SCHEMATIC (EACH SWITCH)



LOGIC DIAGRAM (EACH SWITCH)



ABSOLUTE MAXIMUM RATINGS ($T_a = -40 \sim +85^\circ C$, unless otherwise noted)

Symbol	Parameter	Conditions	Limits	Unit
V_{DD}	Supply voltage		$V_{SS} - 0.5 \sim V_{SS} + 20$	V
V_i	Input voltage		$V_{SS} - 0.5 \sim V_{DD} + 0.5$	V
I_i	Input current	Control inputs	± 10	mA
I_o	Output current		± 10	mA
T_{opr}	Operating temperature range		$-40 \sim +85$	$^\circ C$
T_{stg}	Storage temperature range		$-65 \sim +150$	$^\circ C$

QUADRUPLER BILATERAL SWITCH

RECOMMENDED OPERATING CONDITIONS (Ta = -40 ~ +85°C, VSS = 0V, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min	Typ	Max	
VDD	Supply voltage	3		18	V
VI	Input voltage	0		VDD	V

ELECTRICAL CHARACTERISTICS (VSS = 0V)

Symbol	Parameter	Test conditions	Limits								Unit	
					-40°C		25°C			85°C		
			V _{SS} (V)	V _{DD} (V)	Min	Max	Min	Typ	Max	Min		Max
V _{IH}	High-level input voltage (C _{IN})	Input-to-output current = 10μA	0	5	3.5		3.5			3.5		V
			0	10	7.0		7.0			7.0		
			0	15	11.0		11.0			11.0		
V _{IL}	Low-level input voltage (C _{IN})	Input-to-output current = 10μA	0	5		1.0			1.0		1.0	V
			0	10		1.0			1.0		1.0	
			0	15		1.0			1.0		1.0	
R _{ON}	ON resistance	V _I = 5 V	0	5				600				Ω
		V _I = 2.5V	0	5				6000				
		V _I = 0.25V	0	5				600				
		V _I = 10V	0	10		600			700		900	
		V _I = 5 V	0	10		1300			1500		2000	
		V _I = 0.25V	0	10		600			700		900	
		V _I = 15 V	0	15		430			500		650	
		V _I = 7.5V	0	15		800			950		1200	
		V _I = 0.25V	0	15		430			500		650	
		V _I = 5 V	-5	5		600			700		900	
		V _I = ±0.25V	-5	5		1300			1500		2000	
		V _I = -5 V	-5	5		600			700		900	
	V _I = 7.5V	-7.5	7.5		430			500		650		
	V _I = ±0.25V	-7.5	7.5		800			950		1200		
	V _I = -7.5V	-7.5	7.5		430			500		650		
ΔR _{ON}	ON resistance variations between switches of the same package		-5	5				15				
			-7.5	7.5				10				
I _{OFF}	Input-to-output off-state leakage current	V _{I/O} =10V, V _{O/I} =0 V	0	10					125			nA
		V _{I/O} =0 V, V _{O/I} =10V	0	10					-125			
		V _{I/O} =18V, V _{O/I} =0 V	0	18		250			250		1000	
		V _{I/O} =0 V, V _{O/I} =18V	0	18		-250			-250		-1000	
I _{DD}	Quiescent supply current	V _I (C _{IN}) = V _{DD} , V _{SS}	0	5		1			1		7.5	μA
			0	10		2			2		15	
			0	15		4			4		30	
I _{IH}	High-level input current (C _{IN})	V _{IH} = 18V	0	18		0.3			0.3		1.0	μA
I _{IL}	Low-level input current (C _{IN})	V _{IL} = 0 V	0	18		-0.3			-0.3		-1.0	

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SWITCHING CHARACTERISTICS (Ta = 25°C)

Symbol	Parameter	Test conditions		Limits			Unit		
				V _{SS} (V)	V _{DD} (V)	Min		Typ	Max
f _{max} (I/O)	Maximum transfer frequency	R _L = 2 kΩ	C _L = 15pF Test circuit 2	−5	5		18	MHz	
		R _L = 10kΩ		−5	5		15		
		R _L = 100kΩ		−5	5		12		
f _{max} (C _{I,N})	Maximum control frequency	R _L = 300 Ω	Test circuit 3	0	5		4		
		C _L = 15pF		0	10		10		
				0	15		12		
t _{PLH}	Low-level to high-level and high-level to low-level output propagation time (IN/OUT—OUT/IN)	R _L = 10kΩ C _L = 50pF	Test circuit 4	0	5			100	
0				10			40		
0				15			30		
t _{PHL}				0	5			100	ns
				0	10			40	
				0	15			30	
t _{PLH}	Low-level to high-level and high-level to low-level output propagation time (CONTROL IN—OUT/IN)	R _L = 10kΩ C _L = 50pF	Test circuit 5	0	5			140	
0				10			60		
0				15			50		
t _{PHL}				0	5			140	
				0	10			60	
				0	15			50	
	Sinewave distortion	R _L = 10kΩ f _I = 1 kHz	Test circuit 2	−5	5		0.3		%
	Feedthrough (switch off)	R _L = 1 kΩ	Test circuit 6	−5	5		600		kHz
	Crosstalk (CONTROL IN—OUT/IN)	R _I = 1 kΩ R _L = 10kΩ C _L = 15pF	Test circuit 7	0	5		80 150 210		mV
C _I	Input capacitance	Control input					5		pF
		Switch Input/output					4		

TEST CIRCUITS

1

ON resistance (R_{ON})

$$R_{ON} = 10 \times \frac{(V_i - V_o)}{V_o} \text{ (k} \Omega \text{)}$$

2

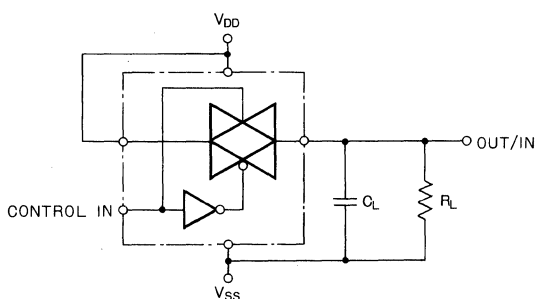
Maximum transfer frequency (f_{max}(I/O))
Sinewave distortion

f_{max}(I/O) is taken as that frequency f_i at which, using a sinewave input of ±2.5V_{P-P}, 20 log₁₀ (V_O/V_i) = -3dB.

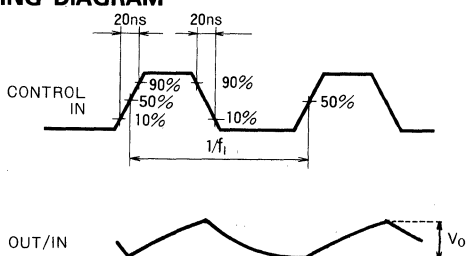
QUADRUPLE BILATERAL SWITCH

3

Maximum control frequency ($f_{\max}(C_{IN})$)



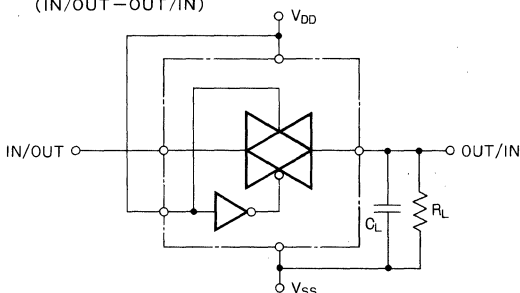
TIMING DIAGRAM



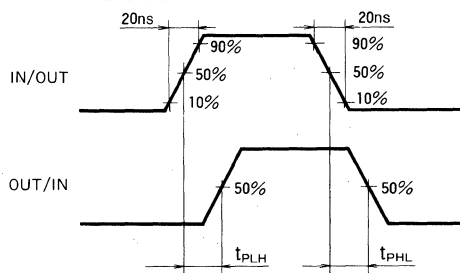
$f_{\max}(C_{IN})$ is taken as that frequency f_i at which the output amplitude V_O is $1/2$ that at 1kHz.

4

Low-level to high-level and high-level to low-level output propagation time (IN/OUT — OUT/IN)

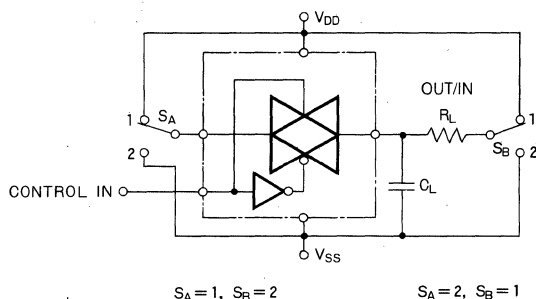


TIMING DIAGRAM

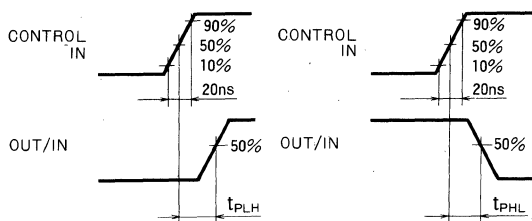


5

Low-level to high-level and high-level to low-level output propagation time (CONTROL IN — OUT/IN)

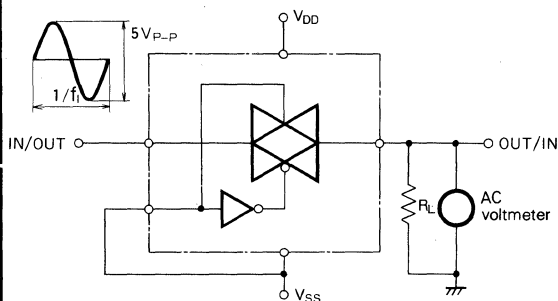


TIMING DIAGRAM



6

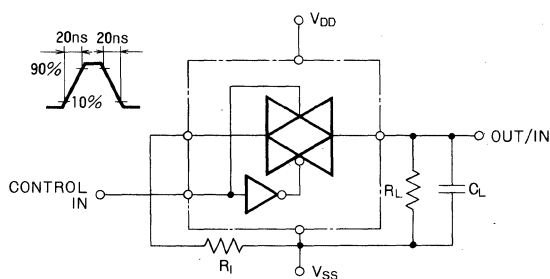
Feedthrough



The feedthrough is taken as that frequency f_i at which, using a sine wave input of $\pm 2.5V_{PP}$, $20 \log_{10} (V_O/V_i) = -50dB$.

7

Crosstalk



QUADRUPLER BILATERAL SWITCH

**Analog switch "ON"
resistance characteristics**

M4016BP

